

Silicon Carbide (SiC) MOSFET - EliteSiC, 960 mohm, 1700 V, M1, TO-247-3L NTHL1000N170M1

Features

- Typ. $R_{DS(on)} = 960 \text{ m}\Omega$
- Ultra Low Gate Charge (typ. Q_{G(tot)} = 14 nC)
- Low Effective Output Capacitance (typ. C_{oss} = 11 pF)
- 100% Avalanche Tested
- RoHS Compliant

Typical Applications

- Solar Inverters
- Electric Vehicle Charging Stations
- Electric Storing Systems
- SMPS (Switch Mode Power Supplies)
- UPS (Uninterruptible Power Supplies)

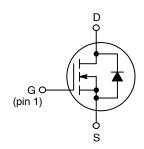
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	1700	V
Gate-to-Source Voltage			V _{GS}	-15/+25	V
Recommended Operation Values of Gate-to-Source Voltage		V_{GSop}	-5/+20	V	
Continuous Drain Current (Note 1)	Steady State	T _C = 25°C	I _D	4.2	Α
Power Dissipation (Note 1)			P _D	48	W
Continuous Drain Current (Note 1)	Steady State	T _C = 100°C	I _D	3	Α
Power Dissipation (Note 1)			P _D	24	W
Pulsed Drain Current (Note 2)	T _C = 25°C		I _{DM}	14	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	9.5	Α
Single Pulse Drain-to-Source Avalanche Energy (Note 3)			E _{AS}	24	mJ
Maximum Lead Temperature for Soldering (1/25" from case for 10 s)			T _L	270	°C

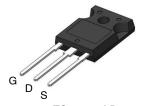
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Repetitive rating, limited by max junction temperature.
- 3. E_{AS} of 24 mJ is based on starting $T_J = 25$ °C; L = 1 mH, I_{AS} = 6.9 A, $V_{DD} = 120$ V, $V_{GS} = 20$ V.

V _{(BR)DSS}	R _{DS(ON)} TYP	I _D MAX
1700 V	960 mΩ @ 20 V	4.2 A

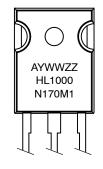


N-CHANNEL MOSFET



TO-247-3LD CASE 340CX

MARKING DIAGRAM



A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

HL1000N170M1 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
NTHL1000N170M1	TO-247-3L	30 Units / Tube

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter		Max	Unit
Junction-to-Case - Steady State (Note 1)		3.1	°C/W

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-,	1			- 7 17		5
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	1 mA	1700			V
Drain-to-Source Breakdown Voltage	V _{(BR)DSS} /T _J	$V_{GS} = 0$ V, $V_{D} = 1$ mA $I_{D} = 1$ mA, referenced to 25°C		1700	0.5		V/°C
Temperature Coefficient	(BH)DSS/1J	(Note 4)	Cu 10 23 O		0.5		V / C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 1700 V	T _J = 25°C			100	μΑ
		V _{DS} = 1700 V	T _J = 175°C			1	mA
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = +25/-15 \text{ V},$	V _{DS} = 0 V			±1	μΑ
ON CHARACTERISTICS (Note 2)							•
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	640 μΑ	1.8	3.2	4.3	V
Recommended Gate Voltage	V_{GOP}			-5		+20	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 20 V, I _D = 2 A	, T _J = 25°C		960	1430	mΩ
		V _{GS} = 20 V, I _D = 2 A, (Note 4)	T _J = 175°C		1800		
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 2	A (Note 4)		0.6		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE (Note	4)					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 1000 V			150		pF
Output Capacitance	Coss				11		1
Reverse Transfer Capacitance	C _{RSS}				0.6		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 800 \text{ V},$			14		nC
Threshold Gate Charge	Q _{G(TH)}	I _D = 2 A			1.5		
Gate-to-Source Charge	Q _{GS}	1			2.6		
Gate-to-Drain Charge	Q_{GD}	1			7.5		
Gate-Resistance	R_{G}	f = 1 MHz			5.7		Ω
SWITCHING CHARACTERISTICS (Notes 4	., 5)						
Turn-On Delay Time	t _{d(ON)}	V _{GS} = -5/20			5.6		ns
Rise Time	t _r	V _{DS} = 800 I _D = 2 A,			30		
Turn-Off Delay Time	t _{d(OFF)}	$R_{G} = 25 \Omega$	2		11		
Fall Time	t _f	inductive load L = 300 μH			84		
Turn-On Switching Loss	E _{ON}				120		μJ
Turn-Off Switching Loss	E _{OFF}				11		
Total Switching Loss	E _{tot}				131		
DRAIN-SOURCE DIODE CHARACTERIST	ics						_
Continuous Drain-Source Diode Forward Current (Note 1)	I _{SD}	V _{GS} = -5 V, T _J	= 25°C			9.5	Α
Pulsed Drain-Source Diode Forward Current (Note 2)	I _{SDM}					48	
Forward Diode Voltage	V_{SD}	$V_{GS} = -5 \text{ V}, I_{SD} = 2 \text{ A}$	A, T _J = 25°C		4.2		٧
Reverse Recovery Time	t _{RR}	$V_{GS} = -5/20 \text{ V, Is}$			5.9		ns
Reverse Recovery Charge	Q _{RR}	dl _S /dt = 1000 A/μs (Note 4)			11		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Defined by design, not subject to production test.

5. E_{ON}/E_{OFF} result is with body diode.

TYPICAL CHARACTERISTICS

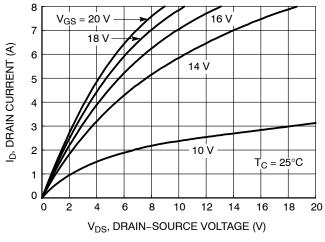


Figure 1. On-Region Characteristics

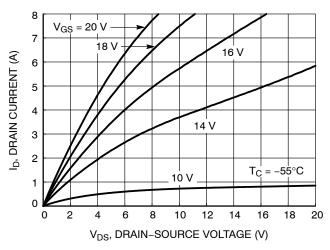


Figure 2. On-Region Characteristics

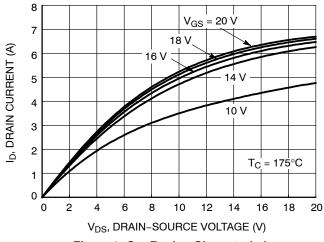


Figure 3. On-Region Characteristics

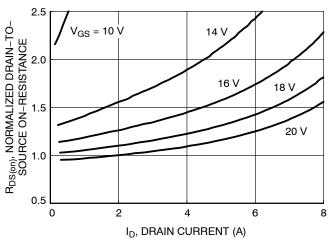


Figure 4. Normalized On-Resistance vs. Drain Current and Gate Voltage

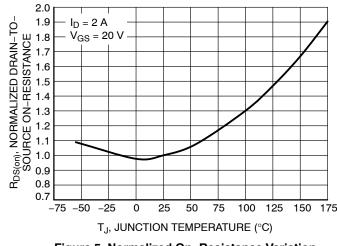


Figure 5. Normalized On-Resistance Variation with Temperature

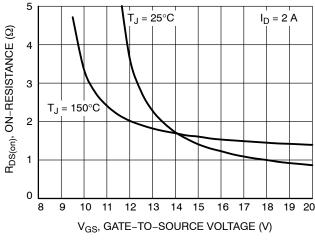


Figure 6. On-Resistance vs. Gate-to-Source Voltage

TYPICAL CHARACTERISTICS

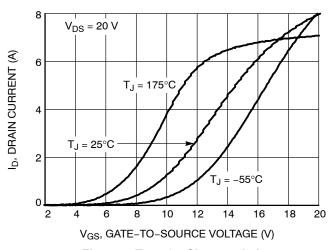


Figure 7. Transfer Characteristics

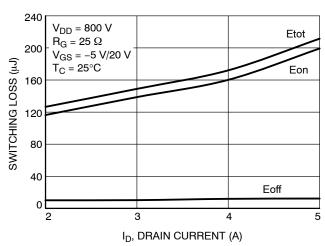


Figure 8. Switching Loss vs. Drain Current

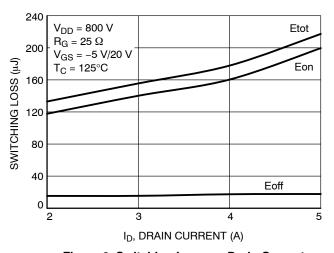


Figure 9. Switching Loss vs. Drain Current

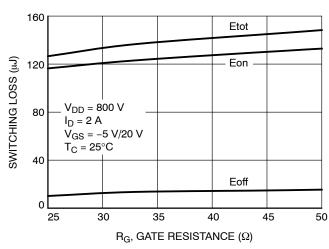


Figure 10. Switching Loss vs. Gate Resistance

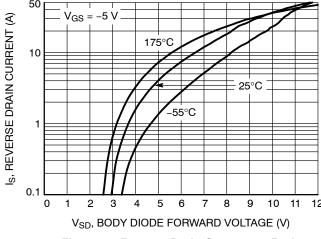


Figure 11. Reverse Drain Current vs. Body Diode Forward Voltage

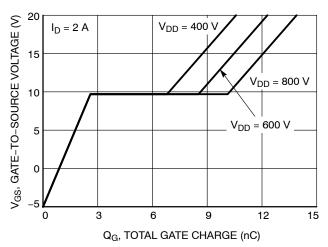


Figure 12. Gate-to-Source Voltage vs. Total Charge

TYPICAL CHARACTERISTICS

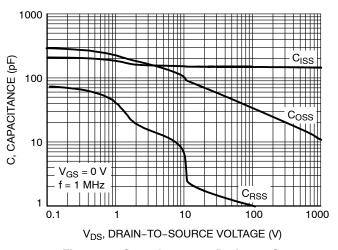


Figure 13. Capacitance vs. Drain-to-Source Voltage

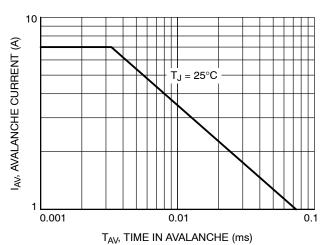


Figure 14. Unclamped Inductive Switching Capability

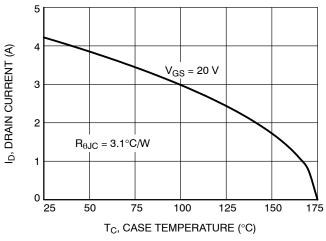


Figure 15. Maximum Continuous Drain Current vs. Case Temperature

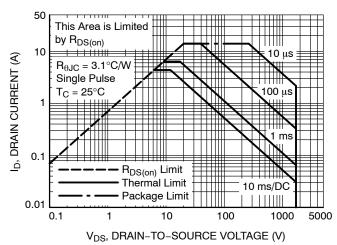


Figure 16. Maximum Rated Forward Biased Safe Operating Area

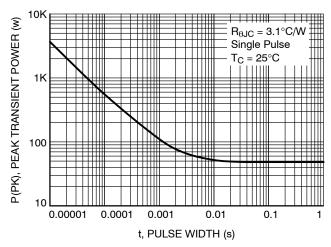


Figure 17. Single Pulse Maximum Power Dissipation

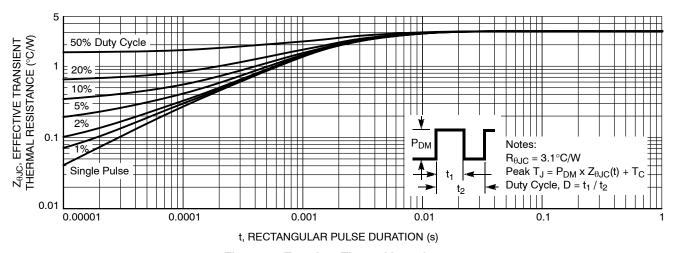


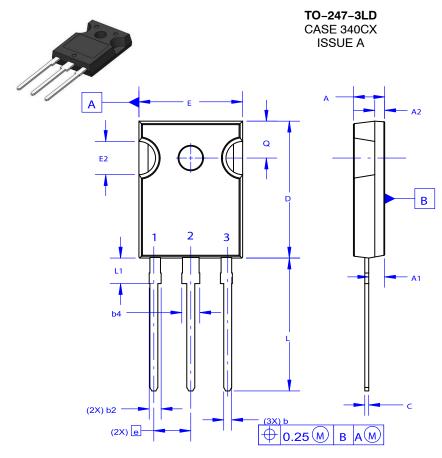
Figure 18. Transient Thermal Impedance

ESD RATINGS

ESD Test	Classification	Standard
ESD-HBM	0B (125 V to <250 V)	ANSI/ESDA/JEDEC JS-001
ESD-CDM	C3 (>1000 V)	ANSI/ESDA/JEDEC JS-002

DATE 06 JUL 2020

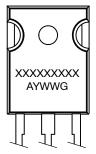




NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

Ø _P —		Φ _{P1} D2
E1 —	2	D1

DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
A 1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
D	20.32	20.57	20.82		
Е	15.37	15.62	15.87		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	19.75	20.00	20.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
E1	12.81	~	~		
ØP1	6.60	6.80	7.00		

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DESCRIPTION:	TO-247-3LD		PAGE 1 OF 1

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